Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/783,767	ALCAZAR ET AL.	
Examiner	Art Unit	
VAN H. NGUYEN	2194	

	SEARCHED		
Class	Subclass	Date	Examiner
719	310, 318	5/27/2007	VN
718	1, 100	5/27/2007	VN
718	104	5/27/2007	VN
709	204, 217	5/27/2007	VN
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
inventor name search	5/27/2007	VN
west, google, IEEE search	5/27/2007	vn
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